

TOSHIBA**HN1D02FU**

TOSHIBA DIODE SILICON EPITAXIAL PLANAR TYPE

HN1D02FU

ULTRA HIGH SPEED SWITCHING APPLICATION.

- HN1D02FU is composed of 2 unit of cathode common.
- Low Forward Voltage : $V_F(3)=0.90V$ (Typ.)
- Fast Reverse Recovery Time : $t_{rr}=1.6ns$ (Typ.)
- Small Total Capacitance : $C_T=0.9pF$ (Typ.)

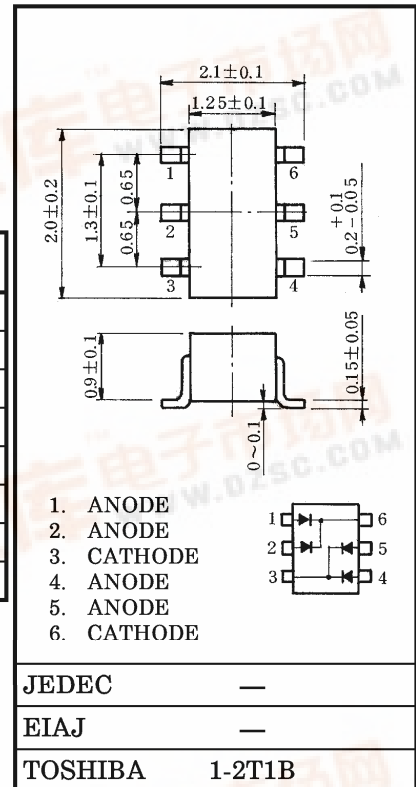
Unit in mm

MAXIMUM RATINGS ($T_a = 25^\circ C$)

CHARACTERISTIC	SYMBOL	RATING	UNIT
Maximum (Peak) Reverse Voltage	V_{RM}	85	V
Reverse Voltage	V_R	80	V
Maximum (Peak) Forward Current	I_{FM}	300*	mA
Average Forward Current	I_O	100*	mA
Surge Current (10ms)	I_{FSM}	2*	A
Power Dissipation	P	200	mW
Junction Temperature	T_j	125	$^\circ C$
Storage Temperature	T_{stg}	-55~125	$^\circ C$

* : This is Maximum Ratings of single diode (Q1 or Q2 or Q3 or Q4).

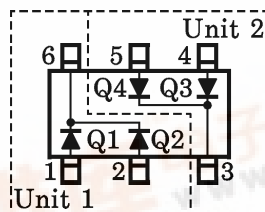
In the case of using Unit 1 and Unit 2 independently or simultaneously, the Maximum Ratings per diode is 75% of the single diode one.

ELECTRICAL CHARACTERISTICS (Q1, Q2, Q3, Q4 COMMON, $T_a = 25^\circ C$)

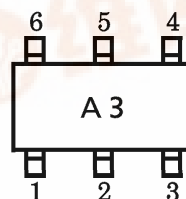
Weight : 6.8mg

CHARACTERISTIC	SYMBOL	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
Forward Voltage	$V_F(1)$	$I_F=1mA$	—	0.60	—	V
	$V_F(2)$	$I_F=10mA$	—	0.72	—	
	$V_F(3)$	$I_F=100mA$	—	0.90	1.20	
Reverse Current	$I_R(1)$	$V_R=30V$	—	—	0.1	μA
	$I_R(2)$	$V_R=80V$	—	—	0.5	
Total Capacitance	C_T	$V_R=0, f=1MHz$	—	0.9	3.0	pF
Reverse Recovery Time	t_{rr}	$I_F=10mA$ (Fig. 1)	—	1.6	4.0	ns

PIN ASSIGNMENT (TOP VIEW)



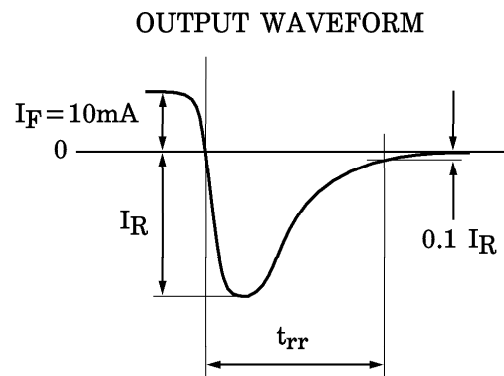
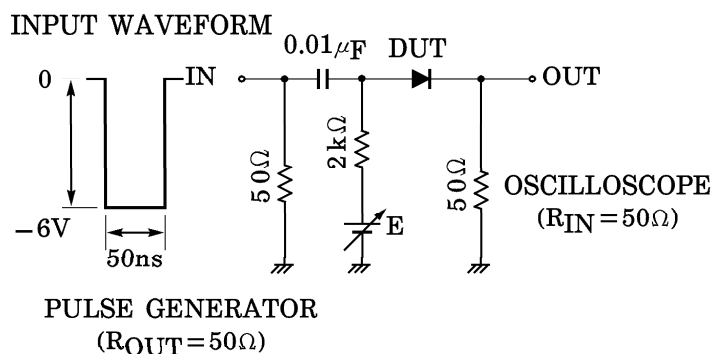
Marking



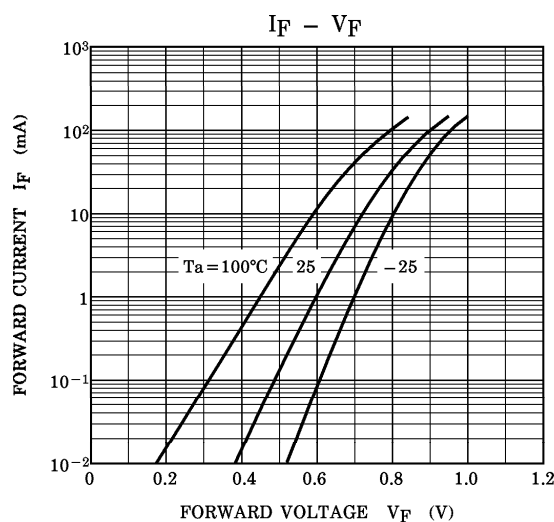
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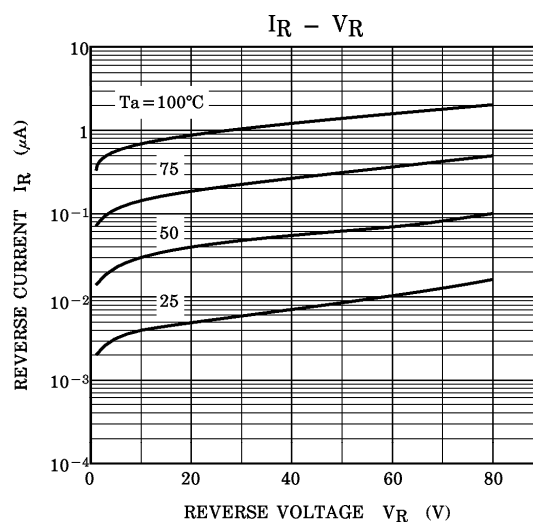
Fig. 1 REVERSE RECOVERY TIME (t_{rr}) TEST CIRCUIT



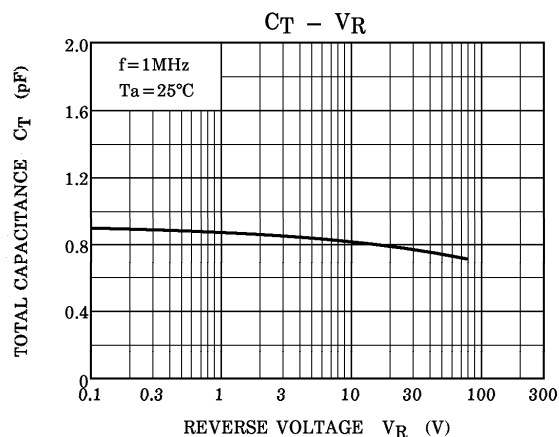
Q1, Q2, Q3, Q4, COMMON



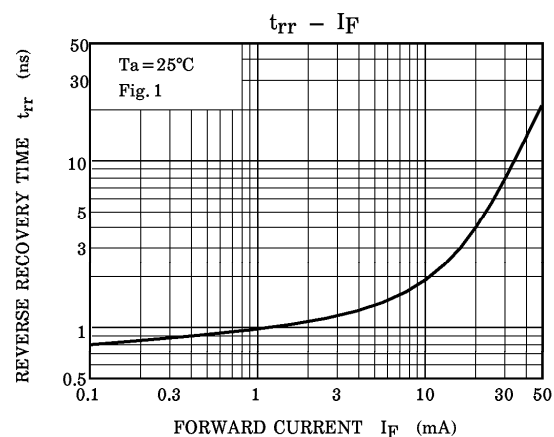
Q1, Q2, Q3, Q4, COMMON



Q1, Q2, Q3, Q4, COMMON



Q1, Q2, Q3, Q4, COMMON



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